## Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 10/598,249 VAN DEN EERENBEEMD, JACOB Examiner Art Unit Page 1 of 1 ILANA SPAR 2629

## II S PATENT DOCUMENTS

U.S. PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2003/0048247	03-2003	Ham, Yong Sung	345/87	
*	В	US-6,304,254	10-2001	Johnson et al.	345/204	
*	С	US-2002/0030652	03-2002	Shibata et al.	345/87	
*	D	US-2003/0058264	03-2003	Takako et al.	345/698	
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	F	US-				
	G	US-		-		
	Н	US-				
	_	US-				
	J	US-				
	К	US-				
	L	US-				
	м	US-				

## FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS								
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## NON DATENT DOCUMENTS

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